N-Channel JFET Monolithic Dual

calogic CORPORATION

SST440 / SST441

FEATURES

- **High Gain . . . . . gf_s > 6 mS typical**
- **Low Leakage . . . . . I_G < 1pA typical**
- **Low Noise**
- **Surface Mount Package**

APPLICATIONS

- **Differential Wideband Amplifiers**
- **VHF/UHF Amplifiers**
- **Test and Measurement**

DESCRIPTION

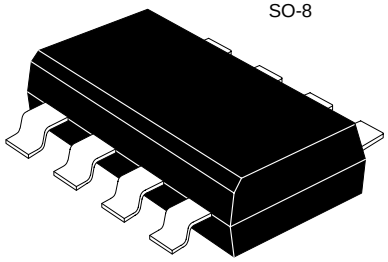
Calogic's SST440 Series is a high speed N-Channel Monolithic Dual JFET in a surface mount SO-8 package. This device is well suited for use as wideband differential amplifiers in test and measurement applications. The combination of high gain, low leakage and low noise make it an excellent performer.

ORDERING INFORMATION

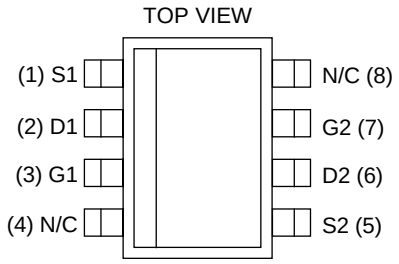
Part	Package	Temperature Range
SST440-1	Plastic SO-8	-55°C to +150°C

NOTE: For Sorted Chips in Carriers, See U440 Series

PIN CONFIGURATION



CJ1



PRODUCT MARKING	
SST440	SST440
SST441	SST441

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Parameter/Test Condition		Symbol	Limit	Unit
Gate-Drain Voltage		V_{GD}	-25	V
Gate-Source Voltage		V_{GS}	-25	V
Forward Gate Current		I_G	50	mA
Power Dissipation	(per side)	P_D	300	mW
	(total)		500	mW
Power Derating	(per side)		2.4	mW/ °C
	(total)		4	mW/ °C
Operating Junction Temperature		T_J	-55 to 150	°C
Storage Temperature		T_{stg}	-55 to 150	°C
Lead Temperature (1/16" from case for 10 seconds)		T_L	300	°C

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

SYMBOL	CHARACTERISTCS	TYP[1]	SST440		SST441		UNIT	TEST CONDITIONS
			MIN	MAX	MIN	MAX		
STATIC								
$V_{(BR)GSS}$	Gate-Source Breakdown Voltage	-35	-25		-25		V	I_G = -1µA, V_{DS} = 0V
$V_{GS(OFF)}$	Gate-Source Cut off Voltage	-3.5	-1	-6	-1	-6		V_{DS} = 10V, I_D = 1nA
I_{DSS}	Saturation Drain Current [2]	15	6	30	6	30	mA	V_{DS} = 10V, V_{GS} = 0V
I_{GSS}	Gate Reverse Current	-1		-500		-500	pA	V_{GS} = -15V, V_{DS} = 0V
		-0.2					nA	T_A = 125°C
I_G	Gate Operating Current	-1		-500		-500	pA	V_{DG} = 10V, I_D = 5mA
		-0.2					nA	T_A = 125°C
$V_{GS(F)}$	Gate-Source Forward Voltage	0.7					V	I_G = 1mA, V_{DS} = 0V
DYNAMIC								
g_{fs}	Common-Source Forward Transconductance	6	4.5	9	4.5	9	mS	V_{DG} = 10V, I_D = 5mA f = 1kHz
g_{os}	Common-Source Output Conductance	20		200		200	µS	
g_{fs}	Common-Source Forward Transconductance	5.5					mS	V_{DG} = 10V, I_D = 5mA f = 100MHz
g_{os}	Common-Source Output Conductance	30					µS	
C_{iss}	Common-Source Input Capacitance	3.5					pF	V_{DG} = 10V, I_D = 5mA f = 1MHz
C_{rss}	Common-Source Reverse Transfer Capacitance	1						
$\overline{e}_n$	Equivalent Input Noise Voltage	4					nV/$\sqrt{Hz}$	V_{DG} = 10V, I_D = 5mA f = 10kHz
MATCHING								
$\lvert V_{GS1}-V_{GS2}\rvert$	Differential Gate-Source Voltage	7		10		20	mV	V_{DG} = 10V, I_D = 5mA
$\frac{\Delta \lvert V_{GS1}-V_{GS2}\rvert}{\Delta T}$	Gate-Source Voltage Differential Change with Temperature	10					µV/ °C	T = -55 to 25°C; V_{DG} =10V, I_D = 5mA
		10						T = 25 to 125°C; V_{DG} =10V, I_D = 5mA
$\frac{I_{DSS1}}{I_{DSS2}}$	Saturation Drain Current Ratio	0.98						V_{DS} = 10V, V_{GS} = 0V
$\frac{g_{fs1}}{g_{fs2}}$	Transconductance Ratio	0.98						V_{DG} = 10V, I_D = 5mA f= 1 kHz
CMRR	Common Mode Rejection Ratio	90					dB	V_{DD} = 5 to 10V, I_D = 5mA

NOTES: 1. For design aid only, not subject to production testing.
2. Pulse test; PW = 300µs, duty cycle ≤ 3%.